

**Notice of References Cited**

Application/Control No.  
09/626,080

Applicant(s)/Patent Under  
Reexamination  
KIM ET AL.

Examiner  
Kenneth N Vanderpuye

Art Unit  
2661

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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B	US-6,754,226 B1		06-2004	Nakano, Takehiko	370/466
C	US-				
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J	US-				
K	US-				
L	US-				
M	US-				

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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